



Schedule of Scope to Certificate of Conformity Approved Process

IECQ Certificate No.: IECQ-P JQAJP 13.0009

CB Certificate No.: JQAQ 0014-001-M

Schedule Number: IECQ-P JQAJP 13.0009-S Rev No.:5 Revision Date:2022/01/19 Page 1 of 1

In respect of standards and specifications:

IEC 60747-1:2006

Semiconductor devices
- Part 1: General

IEC 60748-1:2002

Semiconductor devices - Integrated circuits
- Part 1: General

IEC 60748-20:1988

Semiconductor devices. Integrated circuits
- Part 20: Generic specification for film integrated circuits and
hybrid film integrated circuits

ISO 9001:2015

Quality management systems - Requirements

Component:

Semiconductor devices, Integrated circuits, Hybrid integrated circuits.

Scope:

The design, manufacture and test of Semiconductor devices, Integrated circuits, Hybrid integrated circuits.

This schedule is only valid in conjunction with the referenced Certificate of Approval
This approval and any schedule(s) may only be reproduced in full.
This approval is not transferable and remains the property of the issuing body.
The Status and authenticity of this approval and any schedule(s) may be verified by visiting the
Official IECQ Website. www.iecq.org

Japan Quality Assurance Organization (JQA)
4-4-4, Minamiosawa, Hachioji-shi, Tokyo 192-0364 Japan